


<b>Search Notes</b>  	<b>Application/Control No.</b>  10734159	<b>Applicant(s)/Patent Under Reexamination</b>  TWIG ET AL.
	<b>Examiner</b>  SUSAN Y CHEN	<b>Art Unit</b>  2161

SEARCHED			
Class	Subclass	Date	Examiner
707	10	11/25/08	tyc
715	810	11/25/08	tyc
701	120, 201, 207, 209	11/25/08	tyc
434	130	04/28/09	tyc
715	855	04/28/09	tyc

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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